

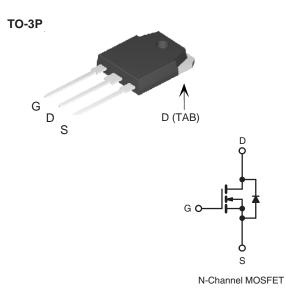
RoHS

COMPLIANT

FQA38N30-VB Datasheet

N-Channel 600V(D-S) Super Junction Power MOSFET

| PRODUCT SUMMARY | | | | | |
|--|-----------------|------|--|--|--|
| V _{DS} (V) at T _J max. | 600 | | | | |
| R _{DS(on)} at 25 °C (Ω) | $V_{GS} = 10 V$ | 0.06 | | | |
| Q _g max. (nC) | 273 | | | | |
| Q _{gs} (nC) | 46 | | | | |
| Q _{gd} (nC) | 79 | | | | |
| Configuration | Single | | | | |



FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C_{iss})
- Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

| ABSOLUTE MAXIMUM RATINGS (T C | = 25 °C, unl | ess otherwis | se noted) | | |
|---|-------------------------|---|-----------------------------------|-------------|------|
| PARAMETER | | | SYMBOL | LIMIT | UNIT |
| Drain-Source Voltage | | | V _{DS} | 600 | V |
| Gate-Source Voltage | | | V _{GS} | ± 30 | v |
| Continuous Drain Current ($T_J = 150 \ ^\circ C$) | V _{GS} at 10 V | $T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$ | I _D | 47 | |
| | V _{GS} at 10 V | V T _C = 100 °C | | 30 | А |
| Pulsed Drain Current ^a | | | I _{DM} | 142 | |
| Linear Derating Factor | | | | 3.3 | W/°C |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 1410 | mJ |
| Maximum Power Dissipation | | | PD | 415 | W |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +150 | °C |
| Drain-Source Voltage Slope | T _J = 125 °C | | -l) / /-lt | 37 | |
| Reverse Diode dV/dt ^d | | | dV/dt | 9 | V/ns |
| Soldering Recommendations (Peak Temperature) ^c | for 10 s | | | 300 | °C |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 10 A.
- c. 1.6 mm from case.
- d. $I_{SD} \leq I_D, \, dI/dt = 100$ A/µs, starting $T_J = 25 \ ^\circ C.$



| THERMAL RESISTANCE RATI | NGS | | | | | | | | |
|--|-----------------------|---|--------------------------------------|----------------------|------|------|-------|------|--|
| PARAMETER | SYMBOL | TYP. MAX. | | | UNIT | | | | |
| Maximum Junction-to-Ambient | R _{thJA} | - 40 | | | | 0044 | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 0.3 | | | | °C/W | | | |
| | | | | | | | | | |
| SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$, u | nless otherwi | se noted) | | | | | | - | |
| PARAMETER | SYMBOL | TES | T CONDIT | IONS | MIN. | TYP. | MAX. | UNIT | |
| Static | | | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = | 250 µA | 600 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, | $I_D = 1 \text{ mA}$ | - | 0.70 | - | V/°C | |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = | 250 µA | 2 | - | 4 | V | |
| Cata Sauraa Laakaga | I _{GSS} | $V_{GS} = \pm 20 \text{ V}$ | | | - | - | ± 100 | nA | |
| Gate-Source Leakage | | | $V_{GS} = \pm 30$ | V | - | - | ± 1 | μA | |
| Zero Gate Voltage Drain Current | I | V _{DS} = | = 650 V, V _G | _{iS} = 0 V | - | - | 1 | | |
| | IDSS | V _{DS} = 520 V, V _{GS} = 0 V, T _J = 125 °C | | | - | - | 25 | μA | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V I _D = 24 A | | - | 0.06 | - | Ω | | |
| Forward Transconductance | 9 _{fs} | V _{DS} = 30 V, I _D = 24 A | | - | 16.7 | - | S | | |
| Dynamic | | • | | | | | | • | |
| Input Capacitance | C _{iss} | | V _{GS} = 0 V, | | | 5682 | - | pF | |
| Output Capacitance | C _{oss} | $V_{DS} = 100 V,$ f = 1 MHz | | - | 251 | - | | | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 1 | - | | | |
| Effective Output Capacitance, Energy Related ^a | C _{o(er)} | V_{DS} = 0 V to 520 V, V_{GS} = 0 V | | - | 192 | - | | | |
| Effective Output Capacitance, Time Related ^b | C _{o(tr)} | | | - | 665 | - | | | |
| Total Gate Charge | Qg | | | | - | 182 | 273 | | |
| Gate-Source Charge | Q _{gs} | $V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, V_{DS} = 520 \text{ V}$ | | - | 46 | - | nC | | |
| Gate-Drain Charge | Q _{gd} | | | | - | 79 | - | | |
| Turn-On Delay Time | t _{d(on)} | V_{DD} = 520 V, I_D = 6 A, V_{GS} = 10 V, R_g = 9.1 Ω | | - | 47 | 94 | - ns | | |
| Rise Time | t _r | | | - | 87 | 131 | | | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 156 | 234 | | | |
| Fall Time | t _f | | | - | 103 | 206 | | | |
| Gate Input Resistance | R _g | f = 1 MHz, open drain | | - | 0.64 | - | Ω | | |
| Drain-Source Body Diode Characteristic | s | | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 47 | A | | |
| Pulsed Diode Forward Current | I _{SM} | | | - | - | 139 | | | |
| Diode Forward Voltage | V _{SD} | T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V | | - | 0.9 | 1.2 | V | | |
| Reverse Recovery Time | t _{rr} | $T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 24 \text{ A},$ dl/dt = 100 A/µs, V _R = 25 V | | - | 753 | 1506 | ns | | |
| Reverse Recovery Charge | Q _{rr} | | | - | 14 | 28 | μC | | |
| Reverse Recovery Current | I _{RRM} | | | - | 28 | - | A | | |

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

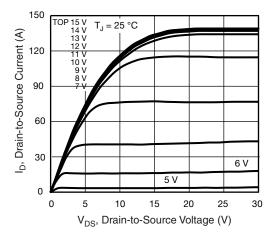


Fig. 1 - Typical Output Characteristics

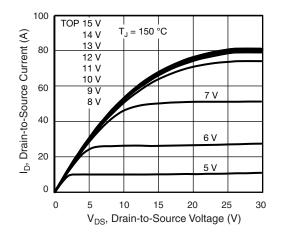


Fig. 2 - Typical Output Characteristics

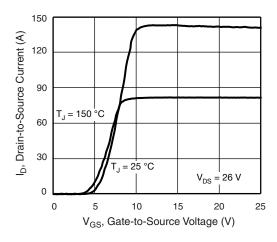


Fig. 3 - Typical Transfer Characteristics

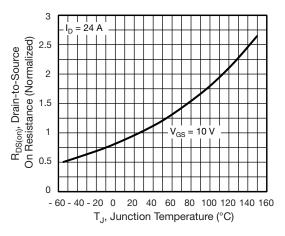


Fig. 4 - Normalized On-Resistance vs. Temperature

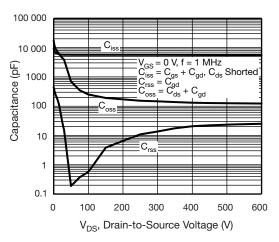


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

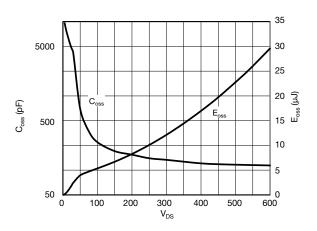


Fig. 6 - Coss and Eoss vs. VDS

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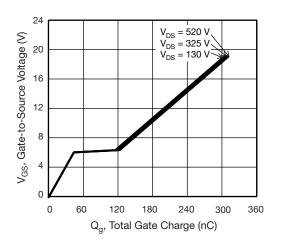


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

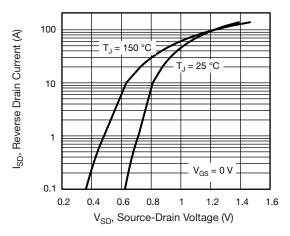


Fig. 8 - Typical Source-Drain Diode Forward Voltage

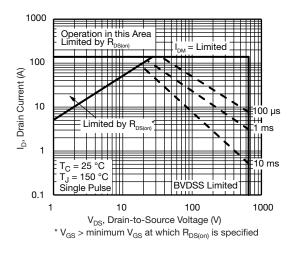
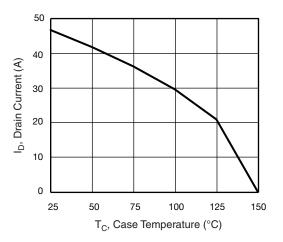


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

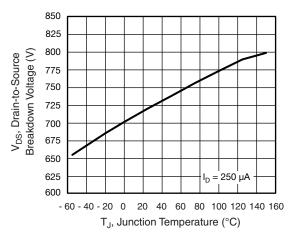
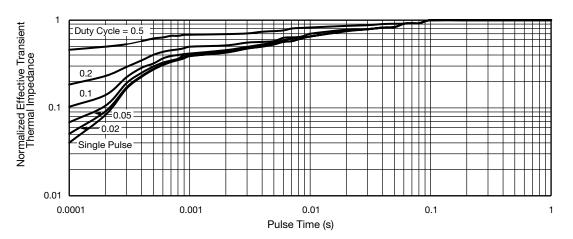


Fig. 11 - Temperature vs. Drain-to-Source Voltage





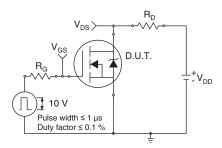


Fig. 13 - Switching Time Test Circuit

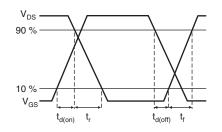


Fig. 14 - Switching Time Waveforms

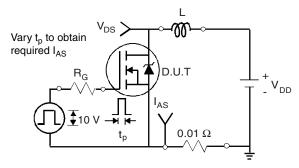


Fig. 15 - Unclamped Inductive Test Circuit

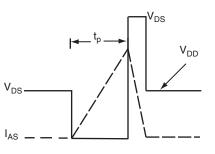


Fig. 16 - Unclamped Inductive Waveforms

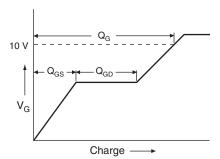


Fig. 17 - Basic Gate Charge Waveform

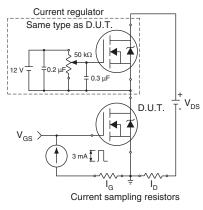


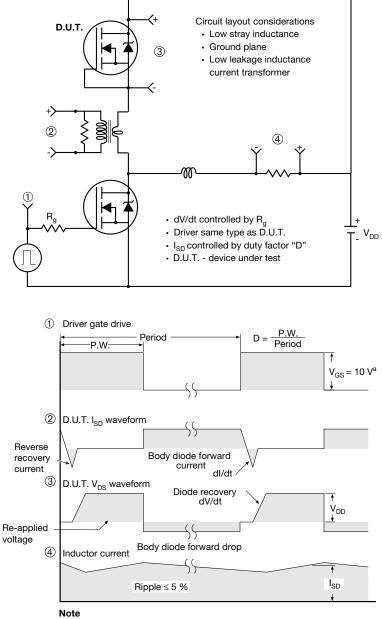
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 V$ for logic level devices

Fig. 19 - For N-Channel



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